## Application/Control No. Applicant(s)/Patent Under Reexamination 09/163,402 SANO ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 Phillip Nguyen 2828 **U.S. PATENT DOCUMENTS Document Number** Date Name Classification Country Code-Number-Kind Code MM-YYYY Α US-US-В US-С US-D US-Ε F US-G US-Н US-US-1 US-J US-K US-L М US-**FOREIGN PATENT DOCUMENTS** Document Number Date Country Name Classification Country Code-Number-Kind Code MM-YYYY JP 03201493 A 09-1991 Ν Japan MIKI, NAOKI H01S 03/134 0 Ρ Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U ٧ W

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.